



Atty.
Dkt. No.

M#

Client Ref

081468

0307331

P-1774.000-US

Applicant: VAN SANTEN et al.

Appln. No. 10/743,271

Filing Date: December 23, 2003

Examiner: Hung Nguyen

Group Art Unit: 2851

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Date: August 24, 2007

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Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
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	BR					
	CR					
	DR					
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	GR					
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	JR					
	KR					
	LR					
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	OR					
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	QR					

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					Enclosed	No	Enclosed	No
HN	RR JP 2005-277363	10/2005	Japan	KOBAYASHI et al.	X		X	
I	SR WO 2005/041276 A1	05/2005	Japan	IMAI et al.	X			
I	TR JP 2005-101488	04/2005	Japan	NEI et al.	X		X	
I	UR JP 2004-259966	09/2004	Japan	NAGASAKA	X		X	
HN	VR JP 11-176727	07/1999	Japan	SHIRAISHI	X		X	
	WR							
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	CC							

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HN	DD	Japanese Office Action issued for Japanese Patent Application No. 2006-545996, dated July 18, 2007.				
	EE	H. Nguyen				

Examiner

Date Considered:

9/5/07

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.



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/H.N./	AR 2005/0231694 A1	10/2005	KOLESNYCHENKO et al.			
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DD	United States Office Action issued for U.S. Patent Application No. 11/473,147, dated March 20, 2007.			
EE	Information Disclosure Statement for U.S. Patent Application No. 11/473,147, filed June 23, 2006.			

Examiner: H. Nguyen Date Considered: 08/06/2007

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FORM PTO-1449 (modified) To: U.S. Department of Commerce (PW FORM PAT-1449) Patent and Trademark Office				Atty. Dkt. No.	M#	Client Ref.	
				081468	0307331	P-1774.000-US	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Applicant: VAN SANTEN et al.			
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				Filing Date: December 23, 2003			
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	CCR						
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U.S. PATENT DOCUMENTS					Appln. No. 10/743,271 Filing Date: December 23, 2003 Examiner: Hung Nguyen Group Art Unit: 2851		
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	KKR					

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